

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NAGASAWA ET AL.	
		Examiner John R. Schnurr	Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0162120 A1	10-2002	Mitchell, Slade	725/135
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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